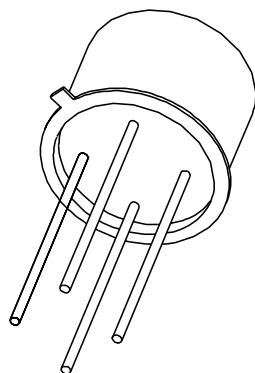


DATA SHEET



BRY39

Programmable unijunction transistor/ Silicon controlled switch

Product specification

1997 Jul 24

Supersedes data of September 1994

File under Discrete Semiconductors, SC04

Programmable unijunction transistor/ Silicon controlled switch

BRY39

FEATURES

- Silicon controlled switch
- Programmable unijunction transistor.

APPLICATIONS

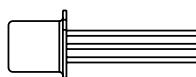
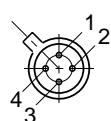
- Switching applications such as:
 - Motor control
 - Oscillators
 - Relay replacement
 - Timers
 - Pulse shapers, etc.

DESCRIPTION

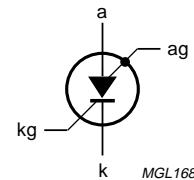
Silicon planar PNPN switch or trigger device in a TO-72 metal package. It is an integrated PNP/NPN transistor pair with all electrodes accessible.

PINNING

| PIN | DESCRIPTION |
|-----|--------------------------------|
| 1 | cathode |
| 2 | cathode gate |
| 3 | anode gate (connected to case) |
| 4 | anode |



MSB028



MGL168

Fig.1 Simplified outline (TO-72) and symbol.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MAX. | UNIT |
|--|---------------------------------|--|------|------|
| Silicon controlled switch | | | | |
| PNP TRANSISTOR | | | | |
| V_{EBO} | emitter-base voltage | open collector | -70 | V |
| NPN TRANSISTOR | | | | |
| V_{CBO} | collector-base voltage | open emitter | 70 | V |
| I_{ERM} | repetitive peak emitter current | | -2.5 | A |
| P_{tot} | total power dissipation | $T_{amb} \leq 25^\circ C$ | 275 | mW |
| T_j | junction temperature | | 150 | °C |
| V_{AK} | forward on-state voltage | $I_A = 50 \text{ mA}; I_{AG} = 0; R_{KG-K} = 10 \text{ k}\Omega$ | 1.4 | V |
| I_H | holding current | $I_{AG} = 10 \text{ mA}; V_{BB} = -2 \text{ V}; R_{KG-K} = 10 \text{ k}\Omega$ | 1 | mA |
| t_{on} | turn-on time | | 0.25 | μs |
| t_{off} | turn-off time | | 15 | μs |
| Programmable unijunction transistor | | | | |
| V_{GA} | gate-anode voltage | | 70 | V |
| I_A | anode current (DC) | $T_{amb} \leq 25^\circ C$ | 175 | mA |
| T_j | junction temperature | | 150 | °C |
| I_p | peak point current | $V_S = 10 \text{ V}; R_G = 10 \text{ k}\Omega$ | 0.2 | μA |

Programmable unijunction transistor/ Silicon controlled switch

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|-------------------------------|--------------------------|------|------|------|
| P _{tot} | total power dissipation | T _{amb} ≤ 25 °C | – | 275 | mW |
| T _{stg} | storage temperature | | –65 | +200 | °C |
| T _j | junction temperature | | – | 150 | °C |
| T _{amb} | operating ambient temperature | | –65 | +150 | °C |

Silicon controlled switch

| | | | | | |
|------------------|---|----------------------------------|--------|-------------|----------|
| V _{CBO} | collector-base voltage PNP NPN | open emitter | – – | –70 70 | V V |
| V _{CER} | collector-emitter voltage PNP NPN | R _{BE} = 10 kΩ | – – | – 70 | V V |
| V _{CEO} | collector-emitter voltage PNP NPN | open base | – – | –70 – | V V |
| V _{EBO} | emitter-base voltage PNP NPN | open collector | – – | –70 5 | V V |
| I _C | collector current (DC) PNP NPN | note 1 | – – | – 175 | mA |
| I _{CM} | peak collector current PNP NPN | note 2 | – – | – 175 | mA |
| I _E | emitter current (DC) PNP NPN | | – – | 175 –175 | mA mA |
| I _{ERM} | repetitive peak emitter current PNP NPN | t _p = 10 µs; δ = 0.01 | – – | 2.5 –2.5 | A A |

Programmable unijunction transistor

| | | | | | |
|-----------------|--------------------|--------------------------|---|-----|----|
| V _{GA} | gate-anode voltage | | – | 70 | V |
| I _A | anode current (AV) | T _{amb} ≤ 25 °C | – | 175 | mA |

Programmable unijunction transistor/ Silicon controlled switch

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| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|-----------------------------------|-------------------------------------|------|------|------------|
| I_{ARM} | repetitive peak anode current | $t_p = 10 \mu s; \delta = 0.01$ | — | 2.5 | A |
| I_{ASM} | non-repetitive peak anode current | $t_p = 10 \mu s; T_j = 150^\circ C$ | — | 3 | A |
| dI_A/dt | rate of rise of anode current | $I_A \leq 2.5 A$ | — | 20 | A/ μs |

Notes

- Provided the I_E rating is not exceeded.
- During switching on, the device can withstand the discharge of a capacitor of a maximum value of 500 pF. This capacitor is charged when the transistor is in cut-off condition, with a collector supply voltage of 160 V and a series resistance of 100 k Ω .

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|--------------|---|-------------|-------|------|
| $R_{th j-a}$ | thermal resistance from junction to ambient | in free air | 450 | K/W |

CHARACTERISTICS $T_{amb} = 25^\circ C$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|----------------------------------|--------------------------------------|---|------|------|---------|
| Silicon controlled switch | | | | | |
| INDIVIDUAL PNP TRANSISTOR | | | | | |
| I_{CEO} | collector cut-off current | $I_B = 0; V_{CE} = -70 V; T_j = 150^\circ C$ | — | -10 | μA |
| I_{EBO} | emitter cut-off current | $I_C = 0; V_{EB} = -70 V; T_j = 150^\circ C$ | — | -10 | μA |
| h_{FE} | DC current gain | $I_E = 1 mA; V_{CE} = -5 V$ | 3 | 15 | |
| INDIVIDUAL NPN TRANSISTOR | | | | | |
| I_{CER} | collector cut-off current | $V_{CE} = 70 V; R_{BE} = 10 k\Omega$ | — | 100 | nA |
| | | $V_{CE} = 70 V; R_{BE} = 10 k\Omega; T_j = 150^\circ C$ | — | 10 | μA |
| I_{EBO} | emitter cut-off current | $I_C = 0; V_{EB} = 5 V; T_j = 150^\circ C$ | — | 10 | μA |
| V_{CEsat} | collector-emitter saturation voltage | $I_C = 10 mA; I_B = 1 mA$ | — | 0.5 | V |
| V_{BEsat} | base-emitter saturation voltage | $I_C = 10 mA; I_B = 1 mA$ | — | 0.9 | V |
| h_{FE} | DC current gain | $I_C = 10 mA; V_{CE} = 2 V$ | 50 | — | |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = 20 V$ | — | 5 | pF |
| C_e | emitter capacitance | $I_C = i_c = 0; V_{EB} = 1 V; f = 1 MHz$ | — | 25 | pF |
| f_T | transition frequency | $I_C = 10 mA; V_{CE} = 2 V; f = 100 MHz$ | 100 | — | MHz |
| COMBINED DEVICE | | | | | |
| V_{AK} | forward on-state voltage | $R_{KG-K} = 10 k\Omega$ | — | 1.4 | V |
| | | $I_A = 50 mA; I_{AG} = 0$ | — | 1.9 | V |
| | | $I_A = 50 mA; I_{AG} = 0; T_j = -55^\circ C$ | — | 1.2 | V |
| I_H | holding current | $V_{BB} = -2 V; I_{AG} = 10 mA; R_{KG-K} = 10 k\Omega; \text{see Fig.14}$ | — | 1 | mA |

Programmable unijunction transistor/ Silicon controlled switch

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| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|--|------------------------------|--|------|------|---------------|
| SWITCHING TIMES | | | | | |
| t_{on} | turn-on time | $V_{KG-K} = -0.5 \text{ to } 4.5 \text{ V}; R_{KG-K} = 1 \text{ k}\Omega$; see Figs 15 and 16 | — | 0.25 | μs |
| | | $V_{KG-K} = -0.5 \text{ to } 0.5 \text{ V}; R_{KG-K} = 10 \text{ k}\Omega$ | — | 1.5 | μs |
| t_{off} | turn-off time | $R_{KG-K} = 10 \text{ k}\Omega$; see Figs 17 and 18 | — | 15 | μs |
| Programmable unijunction transistor | | | | | |
| I_p | peak point current | $V_S = 10 \text{ V}; R_G = 10 \text{ k}\Omega$; see Figs 3 and 8 | — | 0.2 | μA |
| | | $V_S = 10 \text{ V}; R_G = 100 \text{ k}\Omega$; see Figs 3 and 8 | — | 0.06 | μA |
| I_v | valley point current | $V_S = 10 \text{ V}; R_G = 10 \text{ k}\Omega$; see Figs 3 and 8 | — | 2 | μA |
| | | $V_S = 10 \text{ V}; R_G = 100 \text{ k}\Omega$; see Figs 3 and 8 | — | 1 | μA |
| V_{offset} | offset voltage | typical curve; $I_A = 0$; for V_P and V_S see Fig.8 | — | — | V |
| I_{GAO} | gate-anode leakage current | $I_K = 0; V_{GA} = 70 \text{ V}$ | — | 10 | nA |
| I_{GKS} | gate-cathode leakage current | $V_{AK} = 0; V_{KG} = 70 \text{ V}$ | — | 100 | nA |
| V_{AK} | anode-cathode voltage | $I_A = 100 \text{ mA}$ | — | 1.4 | V |
| V_{OM} | peak output voltage | $V_{AA} = 20 \text{ V}; C = 10 \text{ nF}$; see Figs 9 and 11 | 6 | — | V |
| t_r | rise time | $V_{AA} = 20 \text{ V}; C = 10 \text{ nF}$; see Fig.11 | — | 80 | ns |

Explanation of symbols

For application of the BRY39 as a programmable unijunction transistor, only the anode gate is used. To simplify the symbols, the term gate instead of anode gate will be used (see Fig.2).

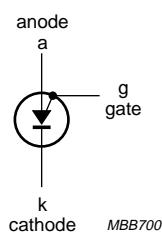


Fig.2 Programmable unijunction transistor explanation of symbols.

Programmable unijunction transistor/ Silicon controlled switch

BRY39

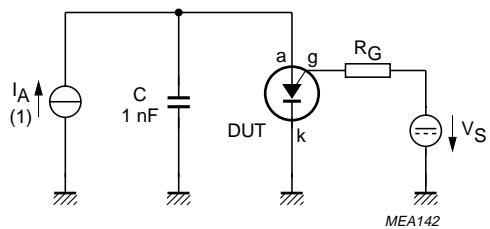


Fig.3 Programmable unijunction transistor test circuit for peak and valley points.

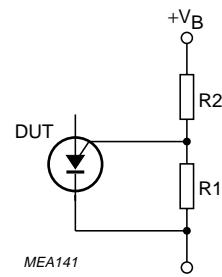


Fig.4 Programmable unijunction transistor with 'program' resistors R1 and R2.

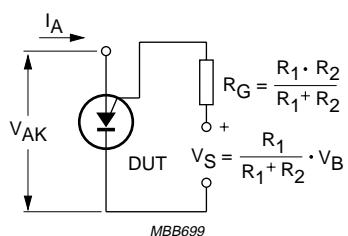


Fig.5 Programmable unijunction transistor equivalent test circuit for characteristics testing.

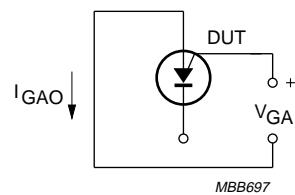


Fig.6 Programmable unijunction transistor equivalent test circuit for gate-anode leakage current.

Programmable unijunction transistor/ Silicon controlled switch

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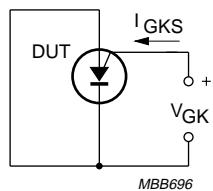


Fig.7 Programmable unijunction transistor equivalent test circuit for gate-cathode leakage current.

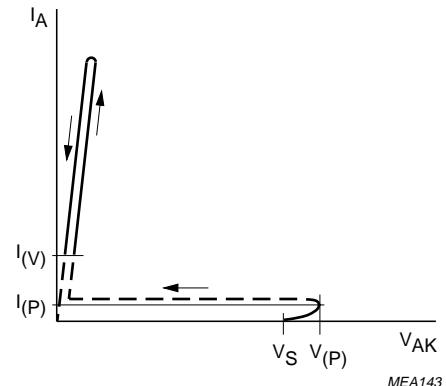


Fig.8 Programmable unijunction transistor offset voltage.

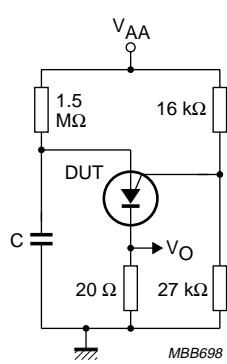


Fig.9 Programmable unijunction transistor test circuit for peak output voltage.

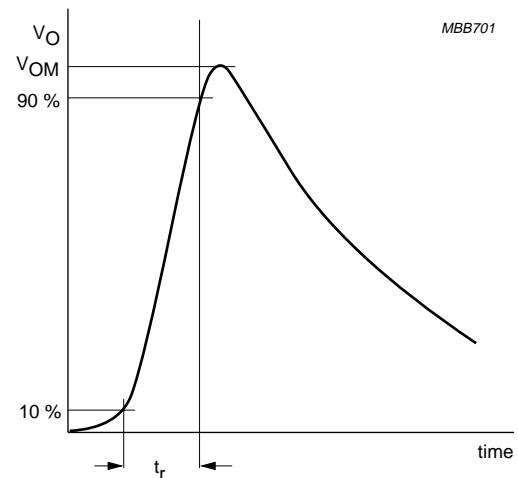


Fig.10 Programmable unijunction transistor peak output voltage.

Programmable unijunction transistor/ Silicon controlled switch

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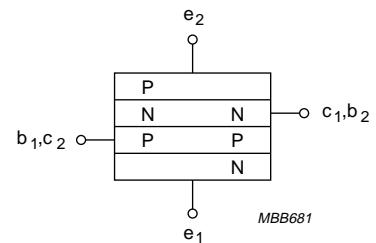
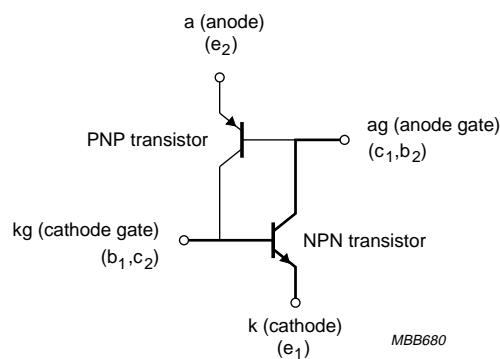
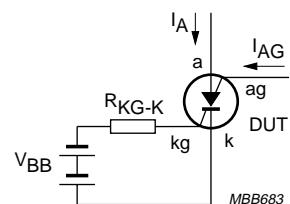
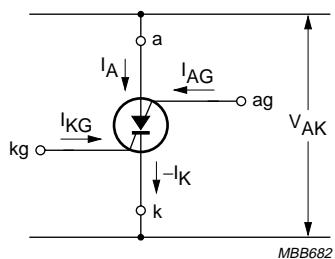


Fig.11 Silicon controlled switch two transistor equivalent circuit.

Fig.12 PNPN silicon controlled switch structure.



Programmable unijunction transistor/ Silicon controlled switch

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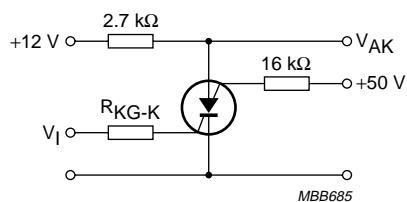


Fig.15 Silicon controlled switch test circuit for turn-on time.

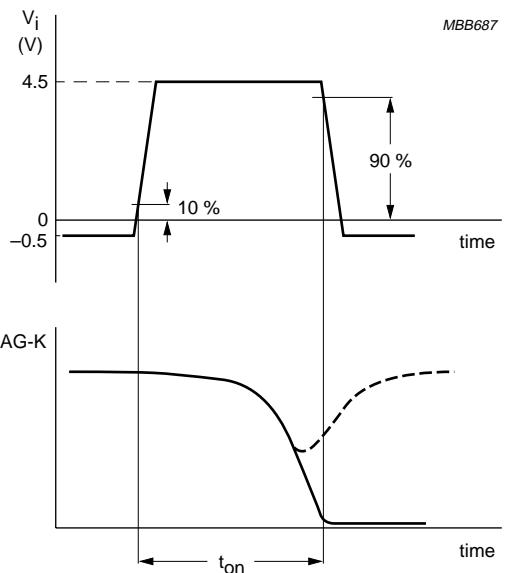


Fig.16 Silicon controlled switch pulse duration increased until dashed curve disappears.

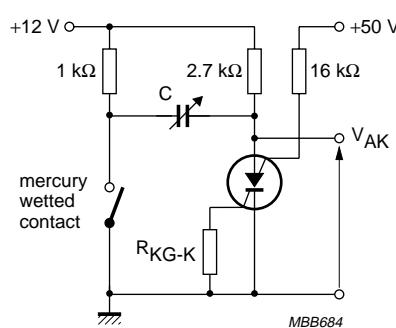


Fig.17 Silicon controlled switch test circuit for turn-on time.

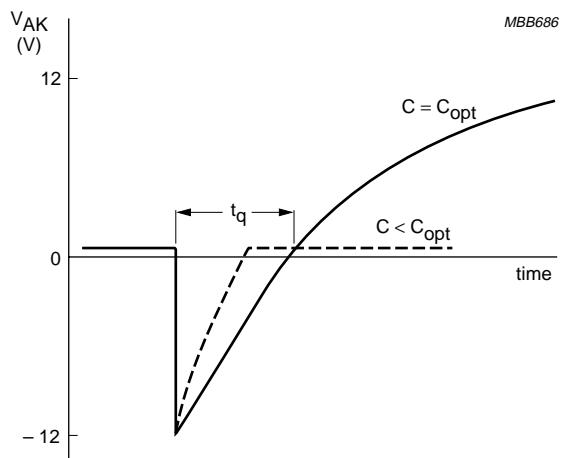
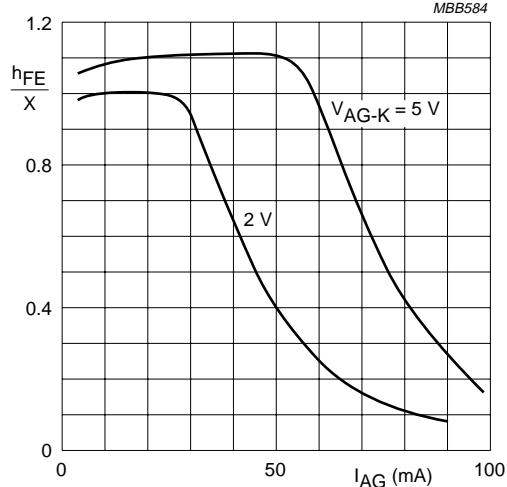


Fig.18 Silicon controlled switch capacitance increased until $C = C_{opt}$ dashed curve disappears.

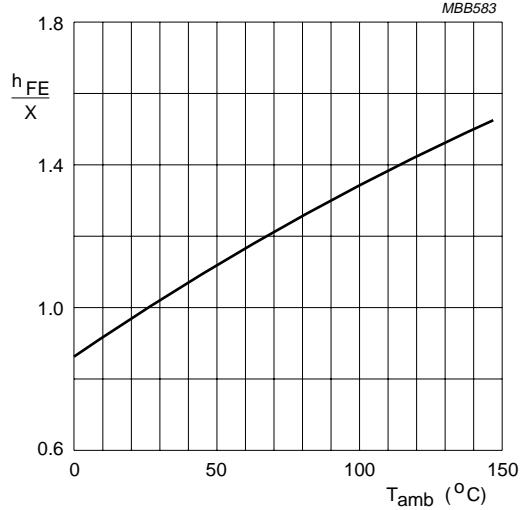
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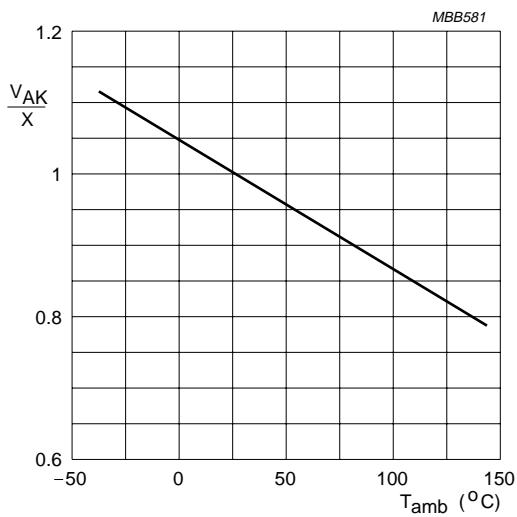
$X = \text{value of } h_{FE} \text{ at } I_C = 10\text{ mA}; V_{AG-K} = 2\text{ V}; T_{amb} = 25^\circ\text{C}.$

Fig.19 Silicon controlled switch normalized DC current gain as a function of anode gate current.



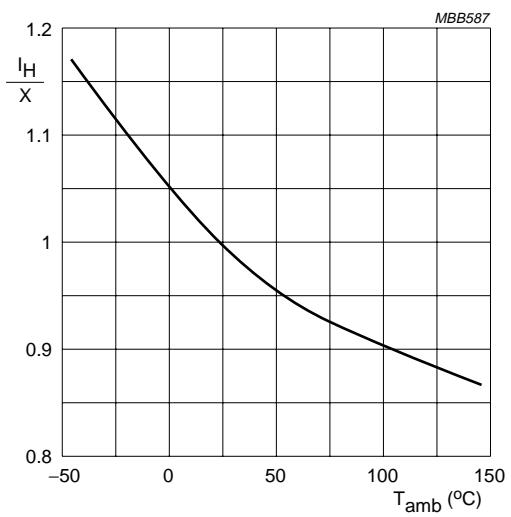
$X = \text{value of } h_{FE} \text{ at } I_{AG} = 10\text{ mA}; V_{AG-K} = 2\text{ V}; T_{amb} = 25^\circ\text{C}.$

Fig.20 Silicon controlled switch normalized DC current gain as a function of ambient temperature.



$X = \text{value of } V_{AK} \text{ at } I_A = 1\text{ mA}; I_{AG} = 10\text{ mA}; V_{BB} = -2\text{ V}; R_{KG-K} = 10\text{ k}\Omega; T_{amb} = 25^\circ\text{C}.$

Fig.21 Silicon controlled switch normalized anode-cathode voltage as a function of ambient temperature.



$X = \text{value of } I_H \text{ at } I_{AG} = 10\text{ mA}; V_{BB} = -2\text{ V}; R_{KG-K} = 10\text{ k}\Omega; T_{amb} = 25^\circ\text{C}.$

Fig.22 Silicon controlled switch normalized holding current as a function of ambient temperature.

Programmable unijunction transistor/ Silicon controlled switch

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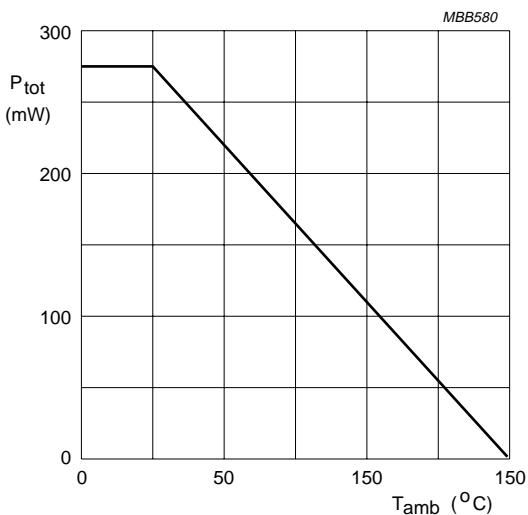


Fig.23 Silicon controlled switch power derating curve.

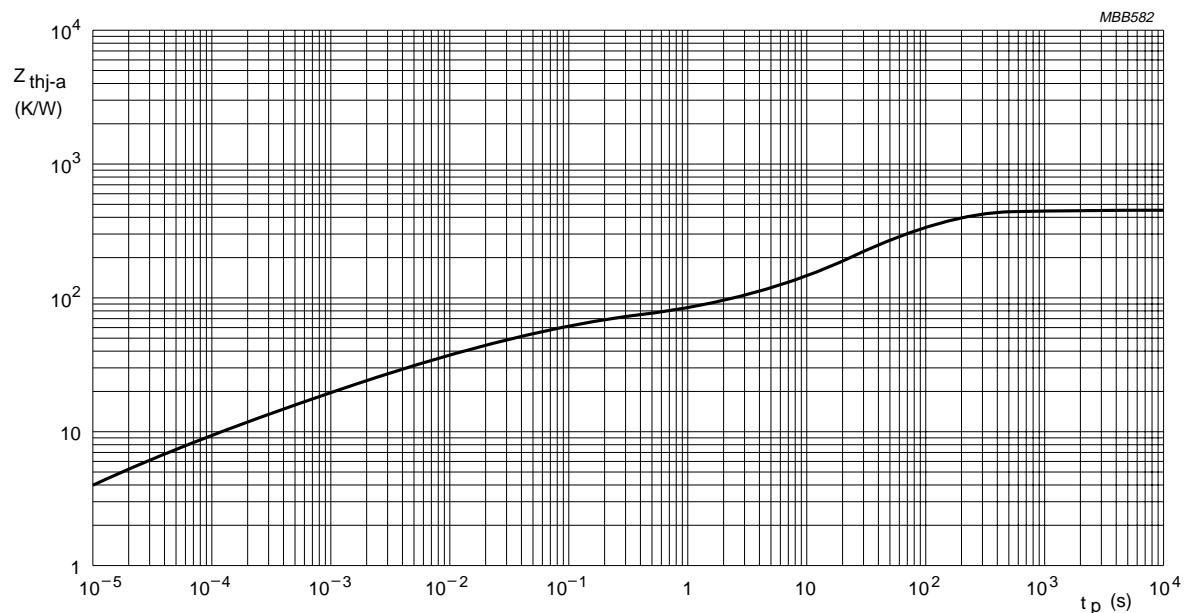


Fig.24 Silicon controlled switch thermal impedance as a function of pulse duration.

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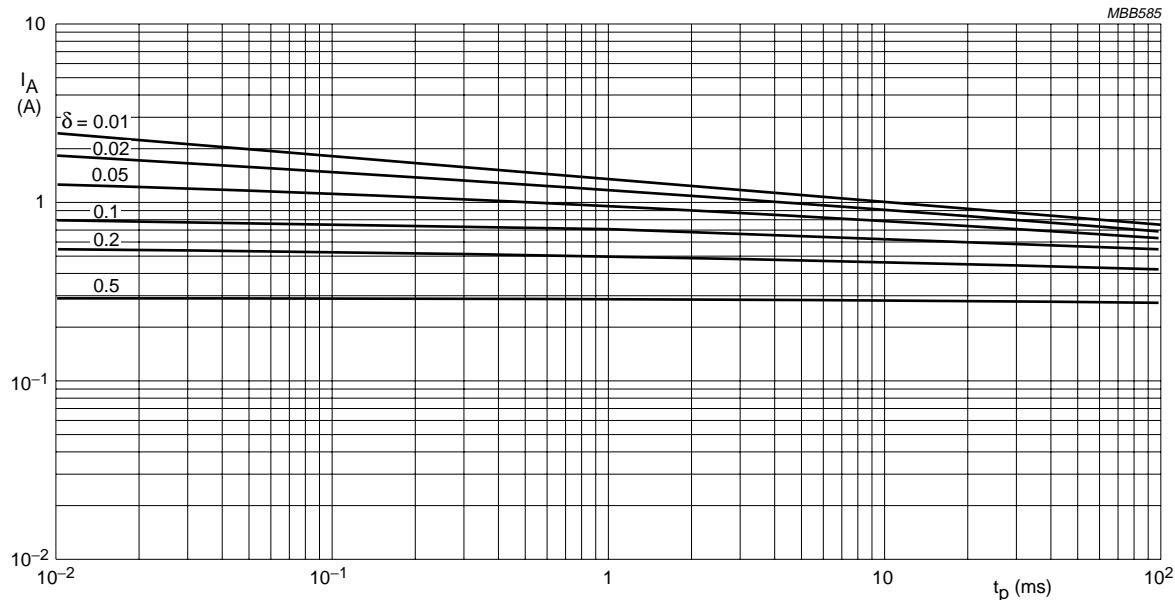
 $T_{amb} = 25^\circ C$.

Fig.25 Silicon controlled switch anode current as a function of pulse duration.

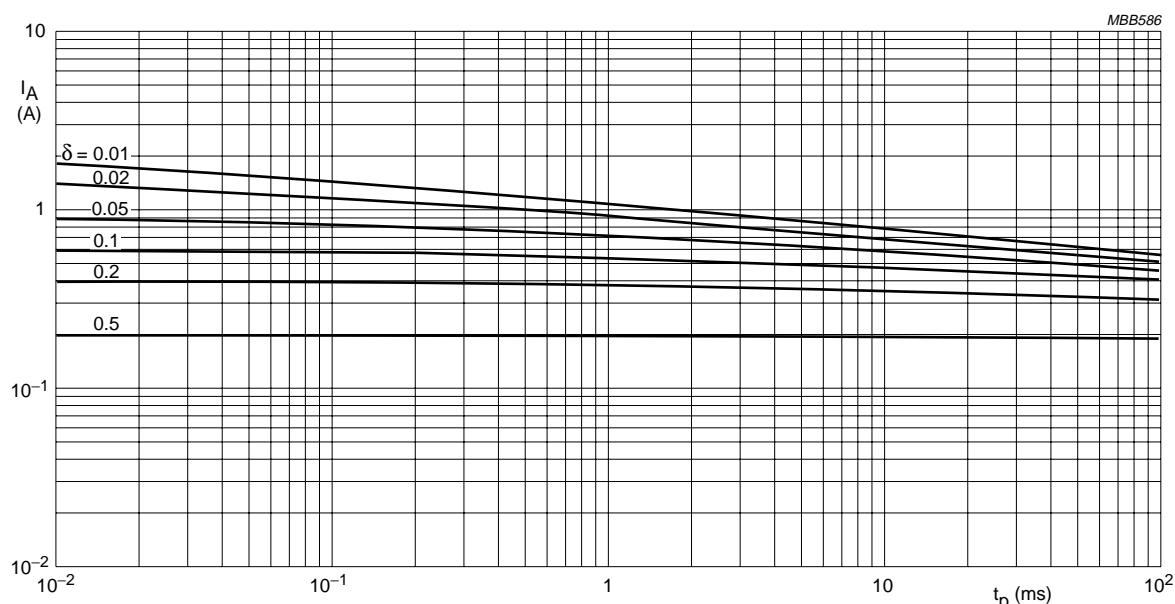
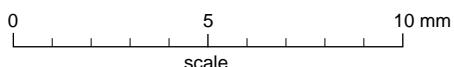
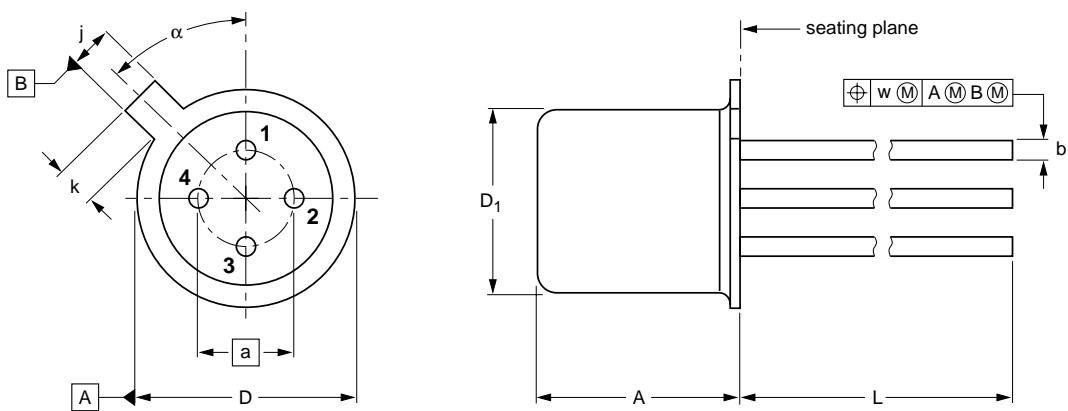
 $T_{amb} = 70^\circ C$.

Fig.26 Silicon controlled switch anode current as a function of pulse duration.

Programmable unijunction transistor/ Silicon controlled switch

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PACKAGE OUTLINE**Metal-can cylindrical single-ended package; 4 leads****SOT18/9****DIMENSIONS** (millimetre dimensions are derived from the original inch dimensions)

| UNIT | A | a | b | D | D ₁ | j | k | L | w | α |
|------|--------------|------|--------------|--------------|----------------|--------------|------------|--------------|------|----------|
| mm | 5.31 4.74 | 2.54 | 0.46 0.42 | 5.45 5.30 | 4.70 4.55 | 1.05 0.95 | 1.0 0.9 | 14.5 13.5 | 0.36 | 45° |

| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|---------------|-------|------|--|---------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
| SOT18/9 | B12/C7 type 3 | TO-72 | | | | 97-04-18 |

Programmable unijunction transistor/ Silicon controlled switch

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DEFINITIONS

| Data sheet status | |
|---|---|
| Objective specification | This data sheet contains target or goal specifications for product development. |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification | This data sheet contains final product specifications. |
| Limiting values | |
| Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability. | |
| Application information | |
| Where application information is given, it is advisory and does not form part of the specification. | |

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These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

Programmable unijunction transistor/
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